

AO3400A 30V N-Channel MOSFET

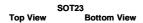
General Description

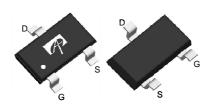
The AO3400A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is suitable for use as a load switch or in PWM applications.

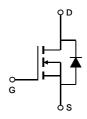
Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 5.7A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 26.5 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 32 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 2.5V) & < 48 m\Omega \end{array}$









Absolute Maximum Ratings T _A =25℃ unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	30	V			
Gate-Source Voltage		V _{GS}	±12	V			
Continuous Drain	T _A =25℃	1	5.7				
Current	T _A =70℃	ID	4.7	A			
Pulsed Drain Current ^C		I _{DM}	30				
	T _A =25℃	В	1.4	W			
Power Dissipation ^B	T _A =70℃	P _D	0.9	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C			

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	70	90	€/M			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	100	125	€/W			
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	€\M			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V			1	μA			
		T _J =55℃			5	μΑ			
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±12V			100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	0.65	1.05	1.45	V			
$I_{D(ON)}$	On state drain current	V_{GS} =4.5V, V_{DS} =5V	30			Α			
R _{DS(ON)} Static [Static Drain-Source On-Resistance	V _{GS} =10V, I _D =5.7A		18	26.5	mΩ			
		T _J =125℃		28	38	11152			
	Static Dialii-Source Off-Resistance	V_{GS} =4.5V, I_D =5A		19	32	mΩ			
		V_{GS} =2.5V, I_D =3A		24	48	mΩ			
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =5.7A		33		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.7	1	V			
Is	Maximum Body-Diode Continuous Curr			2	Α				
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			630		pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =15V, f=1MHz		75		pF			
C _{rss}	Reverse Transfer Capacitance			50		pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	1.5	3	4.5	Ω			
SWITCHI	NG PARAMETERS								
Q_g	Total Gate Charge			6	7	nC			
Q_{gs}	Gate Source Charge	V_{GS} =4.5V, V_{DS} =15V, I_{D} =5.7A		1.3		nC			
Q_{gd}	Gate Drain Charge			1.8		nC			
t _{D(on)}	Turn-On DelayTime			3		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =15V, R_L =2.6 Ω ,		2.5		ns			
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		25		ns			
t _f	Turn-Off Fall Time]		4		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =5.7A, dI/dt=100A/μs		8.5		ns			
Q _{rr}	Body Diode Reverse Recovery Charge I _F =5.7A, dI/dt=100A/μs			2.6		nC			

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.1}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

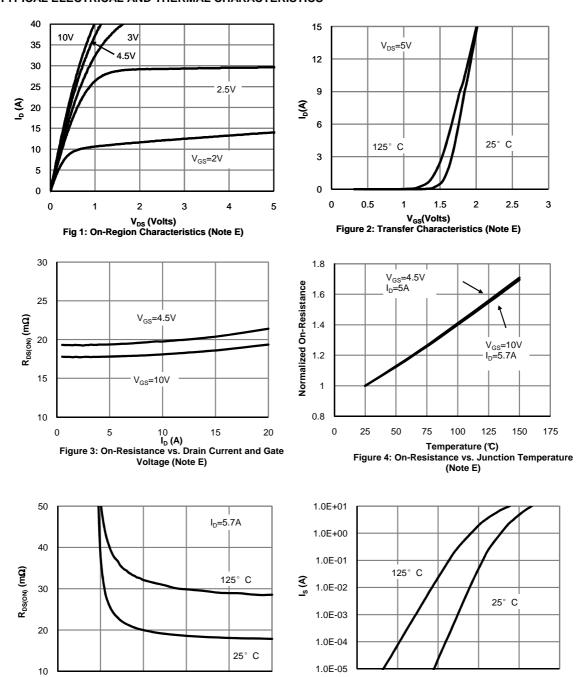
E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(\text{MAX})}$ =150° C. The SOA curve provides a single pulse rating.



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage

(Note E)

0.0

0.2

0.4

V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

0.6

8.0

1.0



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

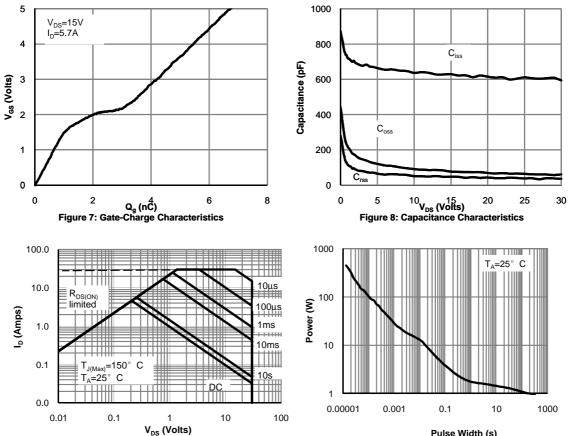


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toAmbient (Note F)

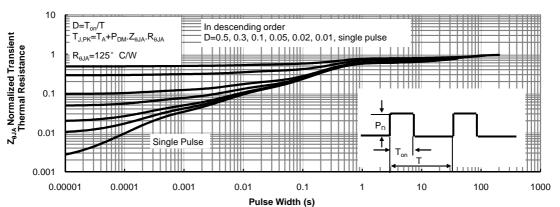
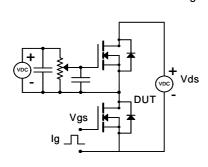
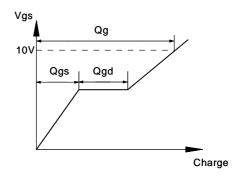


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

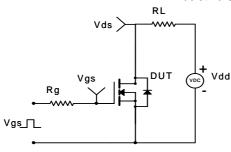


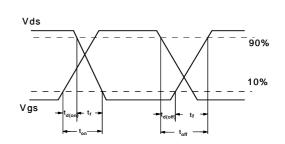
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

